

Search Notes

Application/Control No.

10/791,751

Examiner

Chris C. Chu

Applicant(s)/Patent under
Reexamination

TOMITA ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	758, 700 and 774 - 776	12/22/2004	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USOCR; USPAT; EPO; JPO; DERWENT; and IBM_TDB;	12/22/2004	C.C.